1736 Vista View Drive | Longmont, CO 80504 | tel: 303.776.7249 | fax: 303.776.7314 | info@emcintegrity.com

Test Report Number: ETRB40717

Reference Standard: CFR Title 47, FCC Part 15, Class A

ICES-003, Issue 5, August 2012

Date of Test: 28 July 2014

Date of Report: 30 July 2014

Product Name: STX250-1

Model Number: STX250-1

Serial Number: 443VX

Manufacturer: **Tensitron**

Chris Crosby Representative:

Radiated and Conducted Emissions Report Type:

Test Result: Compliant

Vencent W. Gret **Approved By:**

BSMI FCC

DN: US5316 TSRN: 735190

FRN: 0015264914

SL2-IN-E-1134R

VCCI MSIP MIC US0168 Member #: 2649 Registration #: A-0170

R-3273 C-3642 T-1756 G-233

US0168

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EMC Integrity, Inc. is a Nemko partner lab (ELA-215), and the Nemko certificate and scope of accreditation are contained in the "Laboratory Accreditations" appendix of this report.

The results contained within this report relate only to the product tested. In the event of a discrepancy between EMCI's master report and the report delivered to the client, the EMCI report shall take precedence.

This report shall not be reproduced, except in full, without written approval from EMC Integrity, Inc.

This report must not be used by the client to claim product certification, approval, or endorsement by EMC Integrity, NEMKO, NVLAP, NIST, or any agency of the federal government.

Rev -Total Pages: 52

Prepared for:

Tensitron 733 South Bowen Street Longmont, Colorado 80501 Phone: (303) 415-1112 Fax: (720) 306-4445

Customer Representative:

Chris Crosby President

Tested at:

EMC Integrity, Inc. 1736 Vista View Drive Longmont, Colorado 80504

Tested by:

Kevin Johnson Test Engineer

Report Prepared by:

Mary Burback Office Manager

Report Approved by:

Vincent Greb Laboratory Manager

Revision	Description of Revision	Date:
Rev	Initial Release	30 July 2014

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1.0 TEST SUMMARY

1.1 Product Description

The unit under test (UUT) was the STX250-1. The model number tested was STX250-1 and the serial number tested was 443VX. It is manufactured by Tensitron located in Longmont, Colorado. This product is an electronic tension gauge designed for use in industrial locations. The product was continually exercised during testing, as documented in the "configuration" field of the test data sheet.

Additional information regarding this product may be found in the Product Data Sheet, located in Appendix C of this report.

1.2 Purpose

This report documents the test efforts performed on the STX250-1 to verify compliance to the Class A limits of FCC Part 15 and ICES-003. This was a formal qualification test and was conducted on 28 July 2014.

1.3 Test Standards Used

The emission limits applied to the product tested are defined in CFR Title 47, FCC Parts 15.107 and 15.109. This is the U.S. document which governs electromagnetic emissions from computing devices for conducted and radiated emissions, respectively. The UUT was set up as specified in ANSI C63.4: 2009.

The normative references of this standard define the test methods used for the emissions testing. These standards are contained in Table 1-1.

Table 1-1

CFR Title 47 FCC Part 15	ICES-003, Issue 5, August 2012
ANSI C63.4: 2009	

1.4 Test Results

The UUT **complied** with the Class A emission requirements defined in Table 1-1. Test data is contained in the appropriate appendices of this report.

1.5 Modifications Required for Compliance

None

2.0 TEST ENVIRONMENT

2.1 Radiated Emissions Test Site

Radiated emissions testing was performed at a distance of 10-meters in a semi-anechoic 10-meter chamber. This chamber is calibrated annually and meets the volumetric site attenuation requirements of ANSI C63.4. For measurements from 30 MHz to 1 GHz, a biconilog antenna is used in conjunction with a high-gain, low-noise preamplifier. This is connected to an HP 8566B spectrum analyzer with an HP 85650A Quasi-Peak (QP) Adapter, via an HP 85685 RF Preselector

Radiated emissions testing is broken into two parts: pre-scan and QP/maximization. Pre-scanning a product from 30 MHz to 1 GHz consists of measuring peak emissions from eight radials (every 45 degrees), at four antenna heights (1 m, 2 m, 3 m and 4 m) for both antenna polarities. Data is recorded in a graph showing amplitude vs. frequency of the emissions, and frequencies for QP/maximization are chosen based on this graph. The procedure for maximizing emissions is as follows:

- 1. The analyzer is tuned to the frequency associated with the emissions having the least margin.
- 2. The turntable and antenna mast are moved to the location where the maximum emission was measured during the pre-scan.
- 3. Both are then oriented such that the maximum emission is obtained.
- 4. Cables on the UUT are manually manipulated to achieve the maximum emission.
- 5. The turntable and antenna mast are then re-adjusted to ensure a maximum reading.
- 6. If the signal in question is less than 1 GHz, quasi-peak detection is performed on the signal for a minimum of 10 seconds. For signals greater than 1 GHz, video averaging is performed.
- 7. Turntable/antenna mast maximization and QP detection are performed on all other signals within 6 dB of the limit. In the event that there are not six signals within 6 dB of the limit, the highest six signals are maximized. This ensures that a minimum of six signals are maximized and appear in the final data table.

For emission measurements above 1 GHz, the antenna is changed to a double-ridged horn equipped with a preamplifier and run directly into the spectrum analyzer. The antenna spacing is reduced from 10 meters to 3 meters and RF absorber is placed on the floor between the antenna and the UUT such that the site VSWR requirements of CISPR 16 are achieved. The QP adapter and RF preselector are not used above 1 GHz.

Pre-scanning a product from 1-18 GHz is performed similarly, except that 16 radials (every 22.5 degrees) and three antenna heights (1 m, 1.5 m and 2 m) are used. A similar maximization process is used as for the lower frequency range, except that average measurements are performed, rather than QP measurements.

2.2 Conducted Emissions Test Site

Conducted emissions testing was performed on a 10' by 10' ground plane, which is bonded to the wall of the 10-meter chamber, using its wall as the vertical coupling plane. Line impedance stabilization networks (LISNs) was inserted in series with both the UUT and the support equipment. The LISNs used were standard 50 Ω /50 uH LISNs which complied with the requirements of ANSI C63.4. These LISNs are calibrated annually for both complex impedance and insertion loss. Measurement equipment used was an HP 8566B spectrum analyzer with an HP 85650A QP adapter. In addition, a transient limiter and a high-pass filter are used to protect the front-end of the receiver from transients and low-frequency noise, respectively.

2.3 Measurement Uncertainty

The measurement uncertainty for EMC Integrity's emissions test facility complies with the requirements defined in CISPR 16. The complete calculations of EMC Integrity's measurement uncertainty is contained in an EMCI memo, which is available upon request. However, a summary of EMCI's measurement uncertainty is given in Table 2-1.

Table 2-1

Test	Requirement	Actual
Conducted Emissions	3.60 dB	3.04 dB
Radiated Emissions – Horizontal Polarity	5.20 dB	4.67 dB
Radiated Emissions – Vertical Polarity	5.20 dB	5.01 dB

3.0 Radiated Emissions

3.1 Summary of Test Results

Radiated electric field emissions were measured on the UUT over the frequency range from 30 MHz to 30 GHz. The UUT was powered from 120 Vac/60 Hz, configured in its normal operating mode, and exercised continually during testing. Cables were oriented such that the maximum emission was achieved and quasi-peak detection was performed all signals (minimum of six) used in the final data table. Average detection was performed for all signals that were maximized above 1 GHz.

Test result: Compliant

Margin: 15.45 dB @ 12709.982 MHz

3.2 Test Setup

The UUT was set up in accordance with ANSI C63.4 and tested to the Class A limits specified for unintentional transmitters in FCC 15.109.

3.3 Special Configurations

Not applicable.

3.4 Deviations from Test Procedures

Not applicable.

3.5 Test Data

See APPENDIX A for all test data sheets, test setup pictures and test equipment used.

4.0 Conducted Emissions

4.1 Summary of Test Results

Conducted emissions were measured on the AC power input of the UUT over the frequency range from 150 kHz to 30 MHz. With the UUT configured in its normal operating mode, testing was performed with UUT powered from 120 Vac/60 Hz. The input power to both the UUT and the support equipment was run through standard 50 Ω /50 uH line impedance stabilization networks (LISNs) which complied with the requirements of ANSI C63.4. Emissions were compared to both quasi-peak (QP) and average limits, with QP detection and averaging performed on the six highest signals.

Test result: Compliant

Margin: 23.69 dB @ 0.151 MHz

4.2 Test Setup

The UUT was set up in accordance with ANSI C63.4 and tested to the Class A limits specified for unintentional transmitters in FCC 15.107.

4.3 Special Configurations

Not applicable.

4.4 Deviations from Test Procedures

Not applicable.

4.5 Test Data

See APPENDIX B for all test data sheets, test setup pictures and test equipment used.

APPENDIX A

Radiated Emissions Test Data



Radiated Emissions, FCC Part 15

Manufacturer:	Tensitron	Project Number:	B40717
Customer Representative:	Chris Crosby	Test Area:	10m1
Model:	STX250-1	S/N:	443VX
Standard Referenced:	FCC Part 15	Date:	July 28, 2014
Temperature:	23°C Humidity: 67%	Pressure:	845mb
Input Voltage:	120Vac/60Hz		
Configuration of Unit:	Pre-set load reading		
Test Engineer:	Kevin Johnson		

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Т	E	T1	Transducer	C-: /T	Final	A (-1)/D-1/II	Manain FCC	M
Type	Frequency (MHz)	Level (dBuV)	(dB/m)	Gain / Loss (dB)	rınaı (dBuV/m)	Azm(deg)/Pol/H	Margin: FCC Class A QP (dB)	Margin: FCC
OP	31.052	25.0	20.3	-28.1	17.2	gt(m) 8/V-Pole/2.28	21.89	Class A AV (dB)
QP QP	72.347	32.0	8.4	-28.1	12.8	235/V-Pole/1.54	26.31	-
_ `								-
QP	91.372	37.9	8.2	-27.6	18.5	103/V-Pole/4.00	24.96	-
QP	158.712	28.6	12.1	-27.3	13.4	18/V-Pole/2.39	30.06	-
QP	191.419	27.9	11.4	-27.2	12.1	199/H-Pole/3.71	31.39	-
QP	198.628	34.2	12.3	-27.2	19.3	264/V-Pole/1.00	24.16	-
QP	903.994	24.3	22.4	-24.5	22.3	219/H-Pole/1.00	24.12	-
QP	988.478	24.1	22.9	-24.2	22.8	236/H-Pole/3.29	26.71	-
Type	Frequency	Level	Transducer	Gain / Loss	Final	Azm(deg)/Pol/H	Margin:	Margin:
	(MHz)	(dBuV)	(dB/m)	(dB)	(dBuV/m)	gt(m)	EN55022+FCC	EN55022+FCC
							3m Class A 1-	3m Class A 1-
							40GHz PK (dB)	40GHz AV (dB)
AV	6445.444	54.9	34.7	-53.6	36.0	284/V-Pole/1.00	-	24.50
PK	6445.444	67.5	34.7	-53.6	48.6	284/V-Pole/1.00	31.85	
AV	9357.563	55.6	38.5	-57.4	36.7	183/V-Pole/1.00	-	23.79
PK	9357.563	68.1	38.5	-57.4	49.2	183/V-Pole/1.00	31.29	
AV	12709.982	55.8	39.5	-50.2	45.0	176/V-Pole/1.00	-	15.45
PK	12709.982	68.9	39.5	-50.2	58.2	176/V-Pole/1.00	22.30	
AV	13210.941	55.1	40.1	-53.1	42.1	62/H-Pole/1.00	-	18.39
PK	13210.941	68.1	40.1	-53.1	55.1	62/H-Pole/1.00	25.39	
AV	13704.429	53.4	40.8	-51.9	42.2	107/V-Pole/1.13	-	18.22
PK	13704.429	66.1	40.8	-51.9	55.0	107/V-Pole/1.13	25.47	
AV	14326.248	51.6	41.9	-51.8	41.7	173/V-Pole/1.54	-	18.72
PK	14326.248	64.6	41.9	-51.8	54.7	173/V-Pole/1.54	25.72	

The highest emission measured was at 12709.982 MHz, which was 15.45 dB below the limit.

- > "Type" refers to the type of measurement performed. The type of measurement made is based on the requirements of the particular standard:
 - PK = Peak Measurement: RBW is 120kHz, VBW is 3 MHz
 - QP = Quasi-Peak Measurement: RBW is 120kHz, VBW is 3 MHz, and QP Detection is ENABLED
 - AV = Video Average Measurement: RBW is 1 MHz, VBW is 10 Hz
- The "Final" emissions level is attained by taking the "Level" and adding the "Transducer" factor and the "Gain/Loss" factor. Final measurements are made with the Azimuth, Polarity, Height, and EUT Cables positioned for maximum radiation. If applicable, cables positions are noted in the test log. (Sample Calculation: 49.6 dBuV + 11.4 dB/m 28.8 dB = 32.2 dBuV/m. **Important Note**: This is a sample calculation only for the purpose of demonstration, and does not reflect data in this report.)
- > The "Azm/Pol/Hgt" indicates the turn-table azimuth, the antenna polarity, and the antenna height where the

maximum emissions level was measured.

- > The "Margin" is with reference to the emissions limit. A positive number indicates that the emission measurement is below the limit. A negative number indicates that the emission measurement exceeds the limit.
- > The PRESCAN is a peak measurement and is performed with the RBW set to 120 kHz, VBW set to 3 MHz (30 MHz to 1 GHz), and the RBW set to 1 MHz, VBW set to 100 kHz (> 1 GHz)



Manufacturer: Tensitron Project Number: B40717 Customer Representative: Chris Crosby Test Area: 10m1 STX250-1 S/N: 443VX Model: Standard Referenced: FCC Part 15 July 28, 2014 Date: B40717-11-RE.doc FR0100

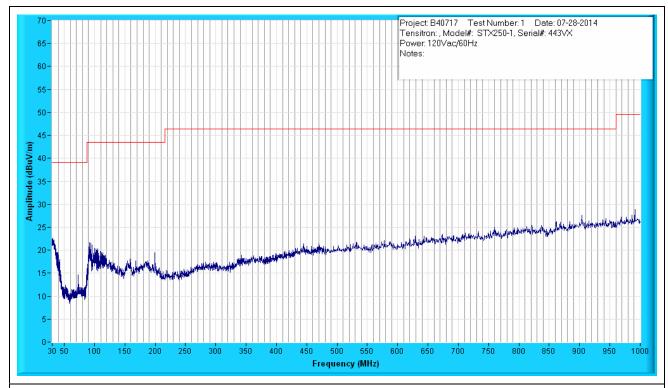


Figure A1: Radiated Emissions Prescan, 30MHz to 1000MHz, Peak Measurements at 10m Distance



Manufacturer:	Tensitron	Project Number:	B40717
Customer Representative:	Chris Crosby	Test Area:	10m1
Model:	STX250-1	S/N:	443VX
Standard Referenced:	FCC Part 15	Date:	July 28, 2014
B40717-11-RE.doc		•	FR0100

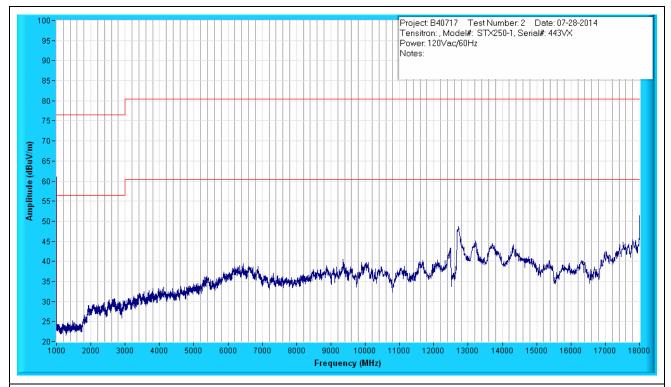


Figure A2: Radiated Emissions Prescan, 1GHz to 18GHz, Peak Measurements at 3m Distance



Manufacturer:	Tensitron	Project Number:	B40717
Customer Representative:	Chris Crosby	Test Area:	10m1
Model:	STX250-1	S/N:	443VX
Standard Referenced:	FCC Part 15	Date:	July 28, 2014
B40717-11-RE.doc		•	FR0100

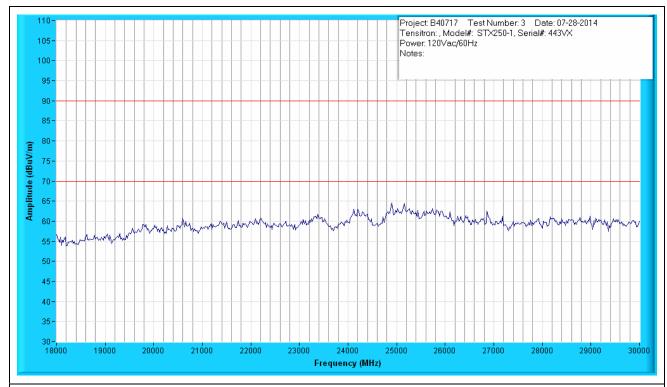


Figure A3: Radiated Emissions Prescan, 18Hz to 30GHz, Peak Measurements at 1m Distance

 Manufacturer:
 Tensitron
 Project Number:
 B40717

 Customer Representative:
 Chris Crosby
 Test Area:
 10m1

 Model:
 STX250-1
 S/N:
 443VX

 Standard Referenced:
 FCC Part 15
 Date:
 July 28, 2014

 B40717-11-RE.doc
 FR0100

B40717

Figure A4: Radiated Emissions Test Setup - Front

 Manufacturer:
 Tensitron
 Project Number:
 B40717

 Customer Representative:
 Chris Crosby
 Test Area:
 10m1

 Model:
 STX250-1
 S/N:
 443VX

 Standard Referenced:
 FCC Part 15
 Date:
 July 28, 2014

 B40717-11-RE.doc
 FR0100



Figure A5: Radiated Emissions Test Setup - Right

 Manufacturer:
 Tensitron
 Project Number:
 B40717

 Customer Representative:
 Chris Crosby
 Test Area:
 10m1

 Model:
 STX250-1
 S/N:
 443VX

 Standard Referenced:
 FCC Part 15
 Date:
 July 28, 2014

 B40717-11-RE.doc
 FR0100



Figure A6: Radiated Emissions Test Setup - Back

Manufacturer: Tensitron Project Number: B40717 Customer Representative: Chris Crosby Test Area: 10m1 STX250-1 443VX Model: S/N: Standard Referenced: B40717-11-RE.doc FCC Part 15 Date: July 28, 2014 FR0100



Figure A7: Radiated Emissions Test Setup – Left

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Radiated Emissions, FCC Part 15

B40717 Manufacturer: Tensitron Project Number: Customer Representative: Chris Crosby Test Area: 10m1 STX250-1 S/N: 443VX Model: Standard Referenced: FCC Part 15
B40717-11-RE.doc Date: July 28, 2014

FR0100

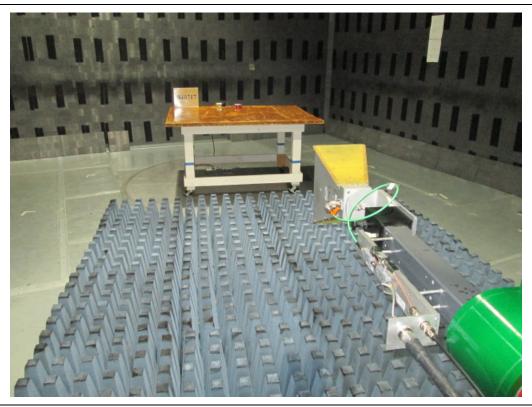


Figure A8: Radiated Emissions Test Setup – 3m



Radiated Emissions, FCC Part 15

Manufacturer:	Tensitron	Project Number:	B40717
Customer Representative:	Chris Crosby	Test Area:	10m1
Model:	STX250-1	S/N:	443VX
Standard Referenced:	FCC Part 15	Date:	July 28, 2014
B40717-11-RE.doc			FR0100

Test Equipment List

ID	Manufacturer	Model #	Serial #	Description	Cal Date	Cal Due
Number						
1030	EMCO	3115	9906-5816	Double-ridged Horn (1 - 18 GHz)	04/28/2014	04/28/2015
1197	EMCO	3116	00040962	DRG Horn 18-40 GHz	11/12/2013	11/12/2014
1219	Mini-Circuits	ZKL-2	062905	Preamp, 10 - 2000 MHz, 30 dB	01/22/2014	01/22/2015
1223	Hewlett Packard	85650A	3303A01859	Quasi-Peak Adaptor	03/13/2014	03/13/2015
1231	Sunol Sciences	JB1	A071605-1	Bilog Antenna, 30 MHz to 2.0 GHz	11/27/2013	11/27/2014
1233	Sunol Sciences	SC104V	110305-1	Positioning Controller	NA	NA
1234	CIR	10m Chamber	001	10m Chamber with 2.5m	11/17/2013	11/17/2014
	Enterprises			turntable		
1238	Sunol Sciences	TWR95-4	110305-3	Antenna Mast	NA	NA
1239	Sunol Sciences	FM2522VS	110305-2	Turn Table, 2.5m Diameter	07/29/2013	07/29/2014
1253	Narda West	1840N506	010-100	18 to 40 GHz Preamplifier, 40dB Gain Nominal	02/17/2014	02/17/2015
1266	California	MX15-1	57961	AC Power Source, 0 - 300 VAC /	NA	NA
	Instruments			16 - 819 Hz / 15kVA		
1276	Narda	DBL-	037-038	1GHz to 18GHz Preamplifier,	05/09/2014	05/09/2015
		0218N308		60dB gain nominal		
1335	Hewlett Packard	85662A	2542A10937	Spectrum Analyzer Display	03/13/2014	03/13/2015
1336	Hewlett Packard	8566B	2532A02062	Spectrum Analyzer RF Section	03/13/2014	03/13/2015

APPENDIX B

Conducted Emissions Test Data



Conducted Emissions, FCC Part 15

Manufacturer:	Tensitron	Project Number:	B40717
Customer Representative:	Chris Crosby	Test Area:	10m1
Model:	STX250-1	S/N:	443VX
Standard Referenced:	FCC Part 15	Date:	July 28, 2014
Temperature:	24°C Humidity: 67%	Pressure:	845mb
Input Voltage:	120Vac/60Hz	'	
Configuration of Unit:	Pre-set load reading	'	
Test Engineer	Kevin Johnson		

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Type	Frequency	Level	Transducer	Gain / Loss	Final	Test Point	Margin: FCC Class	Margin: FCC
-300	(MHz)	(dBuV)	(dB)	(dB)	(dBuV)	1000101110	A AV (dB)	Class A QP (dB)
AV	0.151	27.6	-1.3	16.0	42.3	Line 1	23.69	-
QP	0.151	31.6	-1.3	16.0	46.3	Line 1	-	32.73
AV	0.175	24.4	-1.1	16.0	39.4	Line 1	26.60	=
QP	0.175	28.0	-1.1	16.0	43.0	Line 1	-	36.01
AV	2.088	5.7	-0.5	16.2	21.4	Line 1	38.59	=
QP	2.088	14.0	-0.5	16.2	29.7	Line 1	-	43.25
AV	2.407	2.8	-0.5	16.2	18.5	Line 1	41.46	=
QP	2.407	12.6	-0.5	16.2	28.3	Line 1	=	44.67
AV	11.999	5.8	-0.1	15.8	21.5	Line 1	38.50	-
QP	11.999	11.7	-0.1	15.8	27.4	Line 1	=	45.58
AV	16.000	12.4	0.0	15.7	28.1	Line 1	31.85	-
QP	16.000	15.8	0.0	15.7	31.4	Line 1	=	41.55
AV	0.154	27.1	-1.3	16.0	41.9	Neutral	24.11	=
QP	0.154	30.3	-1.3	16.0	45.1	Neutral	=	33.93
AV	0.171	24.9	-1.1	16.0	39.8	Neutral	26.19	=
QP	0.171	28.2	-1.1	16.0	43.1	Neutral	=	35.87
AV	2.034	4.0	-0.5	16.2	19.7	Neutral	40.35	=
QP	2.034	14.5	-0.5	16.2	30.2	Neutral	=	42.82
AV	2.407	2.9	-0.5	16.2	18.6	Neutral	41.36	=
QP	2.407	13.0	-0.5	16.2	28.8	Neutral	=	44.23
AV	12.000	6.0	-0.1	15.8	21.7	Neutral	38.35	-
QP	12.000	11.8	-0.1	15.8	27.5	Neutral	-	45.46
AV	16.000	12.2	0.0	15.7	27.9	Neutral	32.15	=
QP	16.000	15.6	0.0	15.7	31.3	Neutral	=	41.71

The highest emission measured was at 0.151 MHz, which was 23.69 dB below the limit.

- > "Type" refers to the type of measurement performed. The type of measurement made is based on the requirements of the particular standard:
 - PK = Peak Measurement: RBW is 9 kHz, VBW is 3 MHz
 - QP = Quasi-Peak Measurement: RBW is 9 kHz, VBW is 3 MHz, and QP Detection is ENABLED
 - AV = Video Average Measurement: RBW is 9 kHz, VBW is 10 Hz
- The "Final" emissions level is attained by taking the "Level" and adding the "Transducer" factor and the "Gain/Loss" factor. (Sample Calculation: 40.2 dBuV + 1.6 dB + 16.3 dB = 58.1 dBuV. **Important Note**: This is a sample calculation only for the purpose of demonstration, and does not reflect data in this report.)
- The "TestPoint" indicates which AC or DC input power line or which I/O cable the measurement was made on.
- The "Margin" is with reference to the emissions limit. A positive number indicates that the emission measurement is below the limit. A negative number indicates that the emission measurement exceeds the limit.
- The PRESCAN is a peak measurement and is performed with the RBW set to 9 kHz, and the VBW set to 3 MHz



Conducted Emissions, FCC Part 15

Manufacturer: Tensitron Project Number: B40717 Customer Representative: Chris Crosby Test Area: 10m1 STX250-1 S/N: 443VX Model: July 28, 2014 Standard Referenced: FCC Part 15 Date: B40717-11-CE.doc FR0100

Project: B40717 Test Number: 4 Date: 07-28-2014 Tensitron: , Model#: STX250-1, Serial#: 443VX Power: 120Vac/60Hz 95 Notes: 90 Line 1 80 75 Amplitude (dBuV) 60-55 45 40 35 30-25-20-, 0.1 10.0 Frequency (MHz)

Figure B1: Conducted Emissions Prescan, Line 1, 0.150MHz to 30MHz, Peak Measurements



Conducted Emissions, FCC Part 15

Manufacturer:	Tensitron	Project Number:	B40717
Customer Representative:	Chris Crosby	Test Area:	10m1
Model:	STX250-1	S/N:	443VX
Standard Referenced:	FCC Part 15	Date:	July 28, 2014
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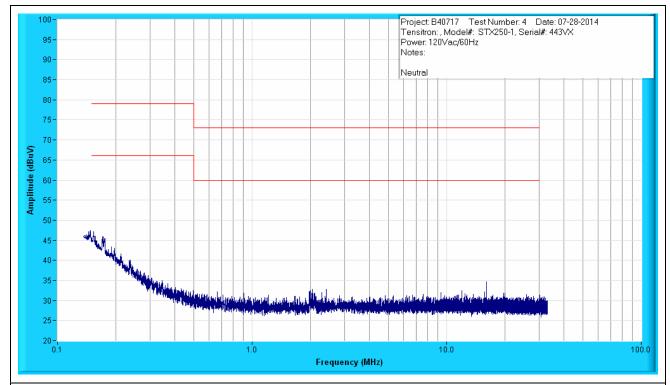


Figure B2: Conducted Emissions Prescan, Neutral, 0.150MHz to 30MHz, Peak Measurements

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Conducted Emissions, FCC Part 15

Manufacturer: Tensitron Project Number: B40717 Customer Representative: Chris Crosby 10m1 Test Area: STX250-1 443VX Model: S/N: Standard Referenced: FCC Part 15
B40717-11-CE.doc July 28, 2014 Date: FR0100

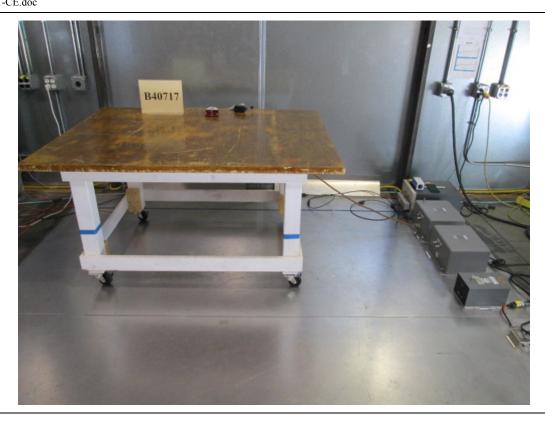


Figure B3: Conducted Emissions Test Setup - Front

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Conducted Emissions, FCC Part 15

 Manufacturer:
 Tensitron
 Project Number:
 B40717

 Customer Representative:
 Chris Crosby
 Test Area:
 10m1

 Model:
 STX250-1
 S/N:
 443VX

 Standard Referenced:
 FCC Part 15
 Date:
 July 28, 2014

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 FR0100



Figure B4: Conducted Emissions Test Setup - Right

Conducted Emissions, FCC Part 15

 Manufacturer:
 Tensitron
 Project Number:
 B40717

 Customer Representative:
 Chris Crosby
 Test Area:
 10m1

 Model:
 STX250-1
 S/N:
 443VX

 Standard Referenced:
 FCC Part 15
 Date:
 July 28, 2014

 B40717-11-CE.doc
 FR0100



Figure B5: Conducted Emissions Test Setup - Back

emc integrity incorporated

Conducted Emissions, FCC Part 15

Manufacturer:	Tensitron	Project Number:	B40717
Customer Representative:	Chris Crosby	Test Area:	10m1
Model:	STX250-1	S/N:	443VX
Standard Referenced:	FCC Part 15	Date:	July 28, 2014
B40717-11-CE.doc			FR0100



Figure B6: Conducted Emissions Test Setup - Left



Conducted Emissions, FCC Part 15

Manufacturer:	Tensitron	Project Number:	B40717
Customer Representative:	Chris Crosby	Test Area:	10m1
Model:	STX250-1	S/N:	443VX
Standard Referenced:	FCC Part 15	Date:	July 28, 2014
B40717-11-CE doc			FR0100

Test Equipment List

ID	Manufacturer	Model #	Serial #	Description	Cal Date	Cal Due
Number				•		
1017	Pacific Power	TMX 140	0256	4 kVA, 50 Hz Power Source	NA	NA
1194	Solar	9252-50-R-24-	042012	LISN	03/18/2014	03/18/2015
		BNC				
1200	Agilent	11947A	3107A03807	Transient Limiter, 9 kHz to 200	01/21/2014	01/21/2015
	Technology			MHz		
1223	Hewlett	85650A	3303A01859	Quasi-Peak Adaptor	03/13/2014	03/13/2015
	Packard					
1335	Hewlett	85662A	2542A10937	Spectrum Analyzer Display	03/13/2014	03/13/2015
	Packard					
1336	Hewlett	8566B	2532A02062	Spectrum Analyzer RF Section	03/13/2014	03/13/2015
	Packard					
1338	Hewlett	85685A	3506A01551	RF Preselector	03/13/2014	03/13/2015
	Packard					
1211	Solar	8131-24	863974	24kHz, 100 dB, High Pass Filter	NA	NA
1539	Extech	445715	Z316007	Hygro-Thermometer	03/21/2014	03/21/2015
	Instruments					

APPENDIX C

Product Data Sheet



www.emcintegrity.com

1736 Vista View Drive | Longmont, CO 80504 | tel: 303.776.7249 | fax: 303.776.7314 | info@emcintegrity.com

1.0 Client Information

Client Information	
Manufacturer Name	Tensitron
Address	733 South Bowen Street
City	Longmont
State	CO
Zip Code	80501
Client Representative	Chris Crosby (CEPD)
Title	President
Phone	(303) 415-1112 Ext 13
Fax	(720) 306-4445
Email	ccrosby@cepd.com

2.0 Product Information - General

Product Information	_
Product Name (as it should appear on test report)	STX250-1
Model Number (of UUT to be tested)	STX250-1
Functional description of product (what is it, what does it	Electronic Tension Gauge
do, etc.)	
List all modes of operation	BATTERY POWER AND/OR POWER SUPPLY
Can modes be operated simultaneously? If so, explain.	YES
What mode(s) will be used for testing?	POWER SUPPLY
Product type (IT, Medical, Scientific, Industrial, etc.)	Industrial
Is the product an intentional radiator	No
Product Dimensions	7" X 9.8" X 2.23"
Product Weight	2-3/4 LBS
Will fork lift be required	No
Applicable Standards, if known	FCC part 15
Describe all environment(s) where product will be used	INDUSTRIAL
(residential, commercial, industrial, etc.)	
Does product consist of multiple components? (If yes,	NO
please describe each system component)	
Cycle time > 3 seconds? (If yes, how long?)	No
Highest internally generated frequency	6 MHz
Product Set-up Time	30 minutes
Boot up time in the event of an unintentional power	< 10 seconds
down	

Identify **ALL** I/O connections on the unit(s) under test, as well as **MAXIMUM** associated cable lengths below

Description	I/O	Гуре	Length (m)	Patient Connect? (See Note)	QTY
	UUT- UUT	UUT - SE			
Power supply			1.5		
		Description UUT- UUT	UUT - SE	Description UUT- UUT (m) UUT - SE	Description UUT- UUT (m) Connect? (See Note)

Note: "Patient Connect" column applies only to medical devices.



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3.0 Power

Power Requirements	
Does/can product connect to AC mains?	Yes
(If so, can the UUT function when connected to AC?)	
Input Voltage Rating as it appears on unit, power supply,	100-240, 50/60 Hz
or power brick	
Input Current (specify @ 230 Vac/50 Hz)	Less than 0.3A
Single or Multi-Phase	Single
(If multi-phase, specify delta or wye)	
Is input power connector two-prong (Hot & Neutral) or	Two-prong
3-prong (H, N, Ground)	
Does UUT have more than 1 power cord? (If yes,	No
explain.)	

4.0 Unit Under Test (UUT) – Detailed Information

		•	<u>′</u>					
UUT Hardwa	are							
Condition		New						
Configuratio During Test	n	Charger	harger connected					
Input Power		Battery	powered and	with chang	er connected			
UUT Compo	nents							
Name	Mod	el No.	Serial	No.	Description			
STX250-1	STX	250-1	443 V	/X	Aircraft Tension Meter			
I/O Cabling	_							
See Section 2	.0 for de	tails						
UUT Softwa	re/Firm	ware						
Name	,	Version/F	Revision		Functionality			
Tensitron_LC	D C	2.01.	109		Full function, production firmware			
UUT Operat	ing Con	ditions						
List all freque	List all frequencies generated/used by the			ONCH a both internal to the unit				
product.				6MHz, 500KHz, both internal to the unit.				
How will product be exercised during test?					ad reading, no user intervention required.			
How will product be monitored during test?			during test?	Visual monitoring of display				
What are the product's critical parameters?				Display reading to stay within +/-2% during testing				
Specify tolerance of all critical parameters.			arameters.	Tension reading, +/- 2%				



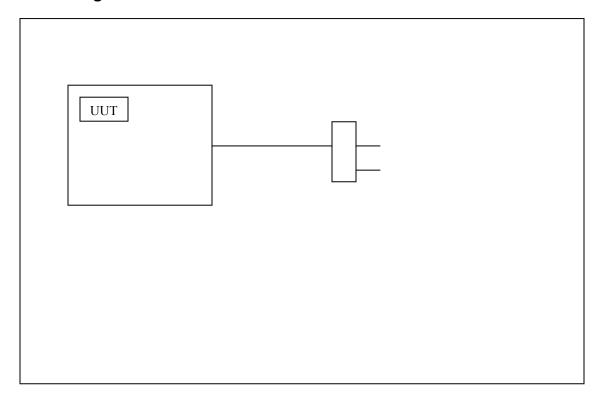
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5.0 Support Equipment (SE) – Detailed Information

Support Eq	uipment (SE)						
Name	Model No.	Serial No.		Description			
None							
SE I/O Cabl	ing						
Model No.		Description		Shielded?	Length	Quantity	
None							
SE Softwar	e/Firmware						
Name	Version/F	Revision	I	Functionality			
None							

6.0 Block Diagram



APPENDIX D

EMI Test Log



EMI Test Log

Manufacturer:	Tensitron	Project Number:	B40717
Model:	STX-1000-1	S/N:	443VX
Customer Representative:	Chris Crosby		
Standard Referenced:	FCC Part 15		

FR0105

10m Emissions

Test	Test	Date	Event	O	Time	Result	Initials
	Code			T	(hrs)		
RE	1312	July 28, 2014	Test#1: 30MHz – 1GHZ, 8 rads, 4 heights, 3 second dwell,		1.5	Pass	KJ
		0800-0930	ref level =80dB, 10 meter distance				
			120Vac/60Hz				
			Pretest verification complete				
RE	1311	0930-1100	Test#2: 1GHz – 18GHZ, 16 rads, 2 heights, 3 second		1.5	Pass	KJ
			dwell, ref level =107dB, 3 meter distance				
			120Vac/60Hz				
RE	1311	1100-1130	Test#3: 18GHz – 30GHz		0.5	Pass	KJ
			120Vac/60Hz				
CE	2311	1130-1200	Test#4: 150KHz – 30MHz		0.5	Pass	KJ
			120Vac/60Hz				

Regular hours: 4.0
Overtime/Prem hours: 4.0
Total hours: 4.0

APPENDIX E

Laboratory Accreditations



Nemko Laboratory Authorization

Authorization: ELA 215

EMC Integrity, Inc. **EMC Laboratory:**

1736 Vista View Drive Longmont, Colorado 80504

Scope of Authorization: All CENELEC standards [ENs] for EMC that are listed on the accompanying page, and all of the corresponding CISPR,

IEC and ISO EMC standards that are listed on the

accompanying page.

Nemko has assessed the quality assurance system, the testing facilities, qualifications and testing practices of the relevant parts of the organization. The quality assurance system of the Laboratory has been validated against ISO/IEC 17025 or equivalent. The laboratory also fulfils the conditions described in Nemko Document NLA -10. During the visit by the Nemko representative it was found that the Laboratory is capable of performing tests within the Scope of the Authorisation.

Accordingly, Nemko will normally accept test results from the laboratory on a partial or complete basis for certification of the products.

In order to maintain the Authorisation, the information given in the pertinent NLA-10 must be carefully followed. Nemko is to be promptly notified about any changes in the situation at the Laboratory, which may affect the basis for this Authorisation. The Authorisation may be withdrawn at any time if the conditions are no longer considered to be fulfilled.

The Authorisation is valid through June 30, 2015.

Dallas, Texas, USA.

For and on behalf of Nemko AS:

BKetterline T.B. Ketterling,

Nemko ELA Co-ordinator Region: North America

Nemko AS Gaustadalléen 30 P.O.Box 73 Blindern N-0314 Oslo Norway T +47 22 96 03 30 F +47 22 96 05 50 Enterprise number NO974404532

SCOPE OF AUTHORIZATION

Capability to perform a basic test implies also that any product (family) standard calling up this basic test is also within the scope if mentioned below or not.

	neric & Product –Family Stand	
EN 55011 :1998+A1 :1999 +A2 :2002 EN 55011:2007 +A2:2007 EN 55011:2009 +A1:2010 CISPR 11:1997 (Modified) + A1:1999 + A2:2002 CISPR 11 Ed. 4.1 CISPR 11 Ed 5.1 (2010-7)	EN55014:1997 +A1:2008 EN 55014-1:2006 +A1:2009 EN 55014-1:2000 + A1:2001 + A2:2002 CISPR 14-1:2000 + A1:2001 + A2:2002 CISPR 14-1:2005 +A1:2008 CISPR 14-1 Ed. 5.0	EN 55014-2:1997 + A1:2001 CISPR 14-2:1997 + A1:2001 +A2:2008 CISPR 14-2 Ed. 1.2
EN 55022: 1998+ A1:2000, +A2:2003 CISPR 22: 2003+ A1:2004 CISPR 22:2005 (Modified) EN55022:2006 CISPR 22 Ed. 5.2 CISPR 22 Ed. 6.0 (2008-09) EN 55022 +A1: 2007	EN 55024: 1998 +A1:2001, +A2:2003 CISPR 24: 1997 +A1:2001, +A2:2002 CISPR 24 Ed. 1.0 EN 55024:2010	EN 61000-6-1 :2007 IEC 61000-6-1 Ed. 2.0 EN 61000-6-1: 2001
EN 61000-6-2:2005 IEC 61000-6-2 Ed. 2.0	EN 61000-6-3 :2007 IEC 61000-6-3 Ed. 2.0 EN 61000-6-3: 2001 + A1 :2004	IEC 61000-6-2 Ed. 2.0 EN 61000-6-2: 2005 IEC 61000-6-2: 2005 EN 61000-6-2: 2001
EN 61326:1997 +A1:1998 + A2:2001 +A3:2003 IEC 61326:1997 + A1:1998 + A2:2000 EN 61326-1 Ed. 1.0 EN 61326-1 :2013 IEC 61326-1 Ed. 2.0 (2012-07) IEC 61326:2006	EN 60601-1-2:2001 + A1:2006 IEC 60601-1-2:2001 EN 60601-1-2:2007 IEC 60601-1-2:2007 (Ed. 3.0)	EN 55103-1:1996 EN 55103-2 :1996 EN 55103-1:2005 EN 55103-2:2005
EN 300 386 V.1.3.1 EN 300 386 V.1.3.3 EN 300 386 V.1.4.1	EN 61000-3-3: 1995, +A1:2001 +A2:2005 IEC 61000-3-3: 1994, +A1:2001 +A2:2005 EN 61000-3-3:2008	EN 61000-3-2: 2000 +A2 :2005 IEC 61000-3-2: 2000 (Modified) +A1:2001 +A2:2004 EN 61000-3-2:2006
EN 50130-4: 1995 + A1:1998 + A2:2002 EN 50130-4:2011	ETSI EN 301 489-x ETSI EN 300 220-x	ETSI EN 300 339 Ed. 1

Bkaterling T.B. Ketterling, Nemko ELA Co-ordinator

NLA 3 ED3

EMC INTEGRITY, INC. Test Report # ETRB40717

	Basic Standards	w.
EN 61000-4-2:1995, +A1:1998, +A2:2000 IEC 61000-4-2:1995, +A1:1998, +A2:2000 EN 61000-4-2:2008 (ed. 2) IEC 61000-4-2:2001 (ed. 1.2)	EN 61000-4-3:2002, +A1:2002 IEC 61000-4-3:2002, +A1:2002 EN 61000-4-3:2006 +A1:2006 +A2:2006 IEC 61000-4-3 (Ed. 3.0) +A1:2007 +A2:2010	EN 61000-4-4:1995, +A1:2002, +A2:2002 IEC 61000-4-4:1995, +A1:2000, +A2:2001 EN 61000-4-4:2004 IEC 61000-4-4 Ed. 2.0 IEC 61000-4-4:2012
EN 61000-4-5:1995, +A1:2001 IEC 61000-4-5:1995, +A1:2000 EN 61000-4-5:2006 IEC 61000-4-5 Ed. 2.0	EN 61000-4-6:1996, +A1:2001 IEC 61000-4-6:1996, +A1:2000 EN 61000-4-6: 2009 IEC 61000-4-6 Ed. 2.2 IEC 61000-4-6: 2008	EN 61000-4-8:1994,+A1:2001 IEC 61000-4-8:1994,+A1:2001 IEC 61000-4-8 Ed. 1.1 IEC 61000-4-8:2001 IEC 61000-4-8:2009 EN 61000-4-8:2010
EN 61000-4-11:2004 IEC 61000-4-11 Ed. 2.0 EN 61000-4-11:1994, +A1:2000 IEC 61000-4-11:1994, +A1:2000	BLANK	BLANK

TBKesterling

T.B. Ketterling, Nemko ELA Co-ordinator

NLA 3 ED3

United States Department of Commerce National Institute of Standards and Technology



Certificate of Accreditation to ISO/IEC 17025:2005

NVLAP LAB CODE: 200737-0

EMC Integrity, Inc.

Longmont, CO

is accredited by the National Voluntary Laboratory Accreditation Program for specific services, listed on the Scope of Accreditation, for:

ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005.

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communique dated January 2009).

2014-07-01 through 2015-06-30

Effective dates



For the National Institute of Standards and Technology

NVLAP-01C (REV. 2009-01-28)





SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005

EMC Integrity, Inc.

1736 Vista View Drive Longmont, CO 80504 Mr. Vincent W. Greb

Phone: 303-776-7249 Fax: 303-776-7314 E-Mail: vinceg@emcintegrity.com URL: http://www.emcintegrity.com

ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NVLAP LAB CODE 200737-0 Scope Revised: 2014-07-17

NVLAP Code Designation / Description

Emissions Test Methods		
12/100063c	IEC 61000-6-3 (1996), EN 61000-6-3 (2001), A1 (2004): Electromagnetic Compatibility (EMC) - Part 6: Generic standards - Section 3: Emission standard for residential, commercial, and light-industrial environments.	
12/610006m	$EN\ 61000\text{-}6\text{-}4\ (2007)\text{:}$ Electromagnetic Compatibility (EMC) - Part 6-4: Generic Standards - Emission Standard for Industrial Environments	
12/61326da	IEC 61326-1 Ed. 2.0 (2012): Electrical equipment for measurement, control and laboratory use - EMC requirements - Part 1: General requirements	
12/CIS11f	AS/NZS CISPR 11 (2002): Industrial, scientific and medical (ISM) radio frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurement	
12/CIS11g	IEC/CISPR 11, Ed. 4.1 (2004-06): Industrial, scientific and medical (ISM) radio-frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurements	
12/CIS11h	AS/NZS CISPR 11 (2004): Industrial, scientific and medical (ISM) radio frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurement	
12/CIS11i	$\label{eq:energy} \begin{array}{l} \text{IEC/CISPR 11, Ed. 4.1 (2004-06)} + \text{A1(2004)}; \\ \text{Industrial, scientific and medical (ISM) radio frequency equipment} \text{ - Electromagnetic disturbance characteristics} \text{ - Limits and methods of measurement} \end{array}$	

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ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

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NVLAP Code	Designation / Description
12/CIS11j	EN 55011 (1998) + A1(1999), A2(2002): Industrial, scientific and medical (ISM) radio frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurement
12/CIS11k	IEC/CISPR 11 (2003), EN 55011 (1998), A2(2002): Limits and Methods of Measurement of Electromagnetic Disturbance Characteristics of Industrial, Scientific, and Medical Radio-Frequency Equipment
12/CIS11m2	EN~55011~(2009) + A1~(2010); Industrial, scientific and medical (ISM) radio-frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurement and the statement of the state
12/CIS11p	IEC/CISPR 11 Ed. 5 (2009-05): Industrial, scientific and medical equipment - Radio-frequency disturbance characteristics - Limits and methods of measurement
12/CIS14b1	AS/NZS CISPR 14-1 (2003): Electromagnetic Compatibility - Requirements for household appliances, electric tools and similar apparatus - Part 1: Emission
12/CIS14x	IEC/CISPR 14-1, Ed. 4 (2003): Electromagnetic Compatibility - Requirements for household appliances, electric tools and similar apparatus - Part 1: Emission
12/CIS22	IEC/CISPR 22 (1997) & EN 55022 (1998) + A1(2000): Limits and methods of measurement of radio disturbance characteristics of information technology equipment
12/CIS22a	IEC/CISPR 22 (1993) and EN 55022 (1994): Limits and methods of measurement of radio disturbance characteristics of information technology equipment, Amendment 1 (1995) and Amendment 2 (1996)
12/CIS22a4	IEC/CISPR 22 (1993) & EN 55022 (1994)+A1(1995), A2(1997): Limits and methods of measurement of radio disturbance characteristics of information technology equipment
12/CIS22b	CNS 13438 (1997): Limits and Methods of Measurement of Radio Interference Characteristics of Information Technology Equipment
12/CIS22e	IEC/CISPR 22, Fourth Edition (2003-04) & EN 55022 (1998): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement

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Rev. - 42 Total Pages: 52





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NVLAP Code	Designation / Description
12/CIS22e1	IEC/CISPR 22, Edition 5 (2005) and EN 55022 (1998): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement
12/CIS22e3	IEC/CISPR 22, Edition 5 (2005) + A1(2005): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement
12/CIS22c4	EN~55022~(1998) + A1(2000) + A2(2003); Information~technology~equipment~-~Radio~disturbance~characteristics~-~Limits~and~methods~of~measurement
12/CIS22f	CNS 13438 (2006) (up to 6GHz): LImits and Methods of Measurement of Radio Interference Characteristics of Information Technology Equipment
12/CIS22i	IEC/CISPR 22, Edition 5.2 (2006-03): Limits and Methods of Measurement of Radio Disturbance Characteristics of Information Technology Equipment
12/CIS22j	EN 55022 (2006): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement
12/CIS22j1	${ m EN}\ 55022\ (2006)$ + ${ m A1}\ (2007)$: Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement
12/CIS22j2	$\rm EN~55022:2010:$ Information technology equipment. Radio disturbance characteristics. Limits and methods of measurement
12/CIS22k	IEC/CISPR 22 (2008-09): Limits and Methods of Measurement of Radio Disturbance Characteristics of Information Technology Equipment
12/EM02d	IEC 61000-3-2, Edition 2.2 (2004-11): Electromagnetic compatibility (EMC) - Part 3-2: Limits - Limits for harmonic current emissions (equipment input current <= 16 A per phase)
12/EM02k	GB 17625.1 (2003): Electromagnetic compatibility (EMC) - Part 3: Limits - Section 2. Limits for harmonic current emissions (equipment input current \leq 16A per phase)
12/EM03b	IEC 61000-3-3, Edition 1.1(2002-03) & EN 61000-3-3, A1(2001): EMC - Part 3-3: Limits - Limitations of voltage changes, voltage flucuations and flicker, in public low-voltage supply-systems, for equipment with rated current <=16 A per phase and not subject to conditional connections

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ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NVLAP LAB CODE 200737-0 Scope Revised: 2014-07-17

NVLAP Code	Designation / Description
12/EM03g	IEC 61000-3-3, Edition 1.1 (2003) +A2 (2005): EMC Part 3-3: Limits - Limitations of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current <= 16 A per phase and not subject to conditional connections
12/EM12e	IEC 61000-3-12 Ed. 2.0 (2011): Electromagnetic compatibility (EMC) - Part 3-12: Limits - Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current $>$ 16 A and = 75 A per phase
12/EM12d	EN 61000-3-12 (2011): Electromagnetic Compatibility (EMC) - PART 3-12: Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current greater than 16A and less than or equal to 75A
12/F18	FCC OST/MP-5 (1986): FCC Methods of Measurement of Radio Noise Emissions for ISM Equipment (cited in FCC Method 47 CFR Part 18 - Industrial, Scientific, and Medical Equipment)
12/FCC15b	ANSI C63.4 (2003) with FCC Method 47 CFR Part 15, Subpart B: Unintentional Radiators
12/FCC15bb	ANSI C63.4 (2009) with FCC Method 47 CFR Part 15, Subpart B: Unintentional Radiators
12/KN11d1	KN11 (Annex 3) with RRA Announce 2008-11 (Dec. 16, 2008): Conformity Assessment Procedure for Electromagnetic Interference; With KN 11 (Annex 3)
12/KN16	Korea RRA Notice No. 2008-11 (Dec. 16, 2008): Conformity Assessment Procedures for Electromagnetic Interference using KN 16-1-1, KN 16-1-2, KN 16-1-3, KN 16-1-4, KN 16-1-5, KN 16-2-1, KN 16-2-2, KN 16-2-3, KN 16-2-4 (2008-05)
12/KN22	KN22 with RRL Notice No. 2005-82 (Sept. 29, 2005): RRL Notice No. 2005-82: Technical Requirements for Electromagnetic Interference Annex 8 (KN-22), RRL Notice No. 2005-131: Conformity Assessment Procedures for Electromagnetic Interference
12/KN22e	KN22 (2008-5) with RRL Notice No. 2008-3 (May 20, 2008): Conformity Assessment Procedure for Electromagnetic Interference; With KN 22
12/KN22f	KN22 (Annex 5) with RRA Announce 2010-5 (Dec 24, 2010): Conformity Assessment Procedure for Electromagnetic Interference; With KN 22 (Annex 5)

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ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NVLAP LAB CODE 200737-0 Scope Revised: 2014-07-17

NVLAP Code	Designation / Description
12/RRA04a	RRA 2014-8 and RRA 2014-37 (June 23, 2014): Technical Requirements and Test Methods for Electromagnetic Interference; K only (See specific Annexes listed on scope)
12/RRA105	RRA Announce 2010-5, K only (December 24, 2010): Conformity Assessment Procedure for Electromagnetic Interference (K only)
12/RRA1118	RRA Public Notification 2011-18, K only (July 5, 2011): Technical Requirements for Electromagnetic Interference (K only)
12/T51	AS/NZS CISPR 22 (2002) and AS/NZS 3548 (1997): Electromagnetic Interference - Limits and Methods of Measurement of Information Technology Equipment
12/T51b1	AS/NZS CISPR 22 (2009): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement
12/TCVNa	$TCVN\ 7189:2009\ (CISPR\ 22:2006): Information\ Technology\ Equipment-Radio\ disturbance\ characteristics\ -\ Limits\ and\ methods\ of\ measurement$
12/VCCIe	Agreement of VCCI V-3 (2009.04): Agreement of Voluntary Control Council for Interference by Information Technology Equipment - Technical Requirements: V-3/2009.04 (radiated disturbance above 1 GHz)
12/VCCIg	Agreement of VCCI V-3 (2011.04): Agreement of VCCI Council - Technical Requirements: V-3/2011.04 (including radiated disturbance above 1 GHz)
12/VCCIi	Agreement of VCCI V-3 (2013.04): Agreement of VCCI Council - Technical Requirements: V-3/2013.04 (including radiated disturbance above 1 GHz)

Immunity Test Methods

12/610006h IEC 61000-6-1, 2nd edition (2005-03): Electromagnetic compatibility (EMC) - Part 6:

Generic standards - Section 1: Immunity for residential, commercial and light-industrial

environments

12/610006i EC 61000-6-2, Edition 2.0 (2005-01): Electromagnetic compatibility (EMC) - Part 6-2:

Generic standards - Immunity for industrial environments

2014-07-01 through 2015-06-30

Effective dates

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ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NVLAP LAB CODE 200737-0 Scope Revised: 2014-07-17

NVLAP Code	Designation / Description
12/61326aa	EN 61326-1:2013: Electrical equipment for measurement, control and laboratory use - EMC requirements - Part 1: General requirements
12/CIS24g	CISPR 24 ed2.0 (2010-08): Information technology equipment - Immunity characteristics - Limits and methods of measurement
12/CIS24h	EN 55024 (2010): Information technology equipment. Immunity characteristics. Limits and methods of measurement
12/I01b	IEC 61000-4-2 (2001); EN 61000-4-2 (2001), A2 (2001): Electrostatic Discharge Immunity Test
12/I01e	EN 61000-4-2 +A1(1998) +A2(2001): Electrostatic Discharge Immunity Test
12/I01d	IEC 61000-4-2, Ed. 2.0 (2008-12): Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test
12/I01f	$EN\ 61000\text{-}4\text{-}2\ (2009\text{-}05)\text{:}$ Electromagnetic compatibility (EMC) - Part 4-2 : Testing and measurement techniques - Electrostatic discharge immunity test
12/І02Ь	IEC/EN 61000-4-3, Ed. 2.1 (2002), A1 (2002); EN 61000-4-3: Radiated, radio-frequency, electromagnetic field immunity test
12/I02c	IEC 61000-4-3 (1995), A1(1998), A2(2000): Radiated, radio-frequency, electromagnetic field immunity test
12/I02f	$EN\ 61000\text{-}4\text{-}3\ (2002) + A1(2002)$: Radiated, radio-frequency, electromagnetic field immunity test
12/I02ggg	IEC 61000-4-3, Ed. 3.0 (2006-02) + A1 (2007) + A2 (2010): Electromagnetic compatibility (EMC) - Part 4-3: Testing measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test
12/I02hhh	EN 61000-4-3 (2006) +A1 (2008) + A2 (2010): Electromagnetic compatibility (EMC). Testing and measurement techniques. Radiated, radio- Frequency, electromagnetic field immunity test

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12/I03c	${\rm IEC~61000\text{-}4\text{-}4, Ed.~2.0~(2004\text{-}07)\text{:} Electromagnetic compatibility~(EMC)\text{-} Part~4\text{-}4\text{:} Testing and measurement techniques - Electrical fast transient/burst immunity test}$
12/I03e	EN 61000-4-4 (2004): Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test
12/I04aa	IEC 61000-4-5, Ed. 2.0 (2005-11); EN 61000-4-5: Electromagnetic Compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test
12/I04b	IEC 61000-4-5 (2001), A1(2000); EN 61000-4-5(2001), A1(2000): Surge Immunity Test
12/I04d	$BS\ EN\ 61000\text{-}4\text{-}5\ (2006)\text{:}$ Electromagnetic compatibility (EMC). Testing and measurement techniques. Surge immunity test
12/I05d	IEC 61000-4-6, Ed. 2.1 (2004); EN 61000-4-6: Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields
12/I05e	$\rm EN61000\text{-}4\text{-}6(1996) + A1(2001)$: Immunity to Conducted Disturbances, Induced by Radio Frequency Fields
12/I05f1	IEC 61000-4-6 Ed. 3.0 (2008): Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields
12/I05j	EN 61000-4-6 (2009): Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields
12/I06b	IEC 61000-4-8 (2001), A1(2000); EN 61000-4-8 (2001), A1(2000): Power Frequency Magnetic Field Immunity Test
12/I06e	EN 61000-4-8 (1993) + A1 (2001): Power Frequency Magnetic Field Immunity Test
12/I06e	IEC 61000-4-8 (2009): Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test

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12/I06f	EN 61000-4-8:2010: Electromagnetic compatibility (EMC). Testing and measurement techniques. Power frequency magnetic field immunity test
12/I07c	$\label{eq:encoder} \begin{tabular}{ll} EC 61000-4-11, Ed. 2 (2004-03) \& EN 61000-4-11; Electromagnetic compatibility (EMC) - Part 4-11; Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests \\ \end{tabular}$
12/I07e	$\rm EN$ 61000-4-11 (1994), A1 (2001): Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests
12/I07f	EN 61000-4-11 (2004): Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests
12/KN11a	$KN\ 61000\text{-}4\text{-}11$ with RRL Notice No. 2005-130 (Dec 27, 2005): Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests
12/KN11f	KN 61000-4-11 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests
12/KN11h	KN 61000-4-11 (Annex 1-7) RRA Announce 2010-6 (Dec.24, 2010): Conformity Assessment Procedure for EMS (Voltage Dips, Short Interruptions and Voltage Variations Immunity tests)
12/KN24	KN24 (December 2005) with RRL Notice No. 2005-83: Information Technology Equipment - immunity characteristics - limits and methods of measurements
12/KN24d	KN 24 (2008-5) with RRL Notice No. 2008-4 (May 20, 2008): Information Technology Equipment - immunity characteristics - limits and methods of measurements
12/KN24e	KN 24 (Annex 5) with RRA Announce 2010-6 (Dec. 24, 2010): Conformity Assessment Procedure for EMS (Information technology equipment - Immunity characteristics - Limits and methods of measurement)
12/KN2a	KN 61000-4-2 with RRL Notice No. 2005-130 (Dec. 27, 2005): Electrostatic Discharge Immunity Test

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12/KN2e	KN 61000-4-2 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Electrostatic Discharge Immunity Test
12/KN2e	KN 61000-4-2 (Annex 1-1) RRA Announce 2010-6 (Dec. 24, 2010): Conformity Assessment Procedure for EMS (Electrostatic Discharge Immunity Test)
12/KN3a	KN 61000-4-3 with RRL Notice No. 2005-130 (Dec. 27, 2005): Radiated, radio-frequency, electromagnetic field immunity test
12/KN3e	KN 61000-4-3 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Radiated, radio-frequency, electromagnetic field immunity test
12/KN3e	KN 61000-4-3 (Annex 1-2) RRA Announce 2010-6 (Dec. 24, 2010): Radiated, radio-frequency, electromagnetic field immunity test
12/KN4a	KN 61000-4-4 with RRL Notice No. 2005-130 (Dec. 27, 2005): Electromagnetic compatibility (EMC): Testing and measurement techniques - Electrical Fast Transient/Burst Immun
12/KN4c	KN 61000-4-4 (2008-5); RRL Notice No. 2008-5 (May 20, 2008): Electromagnetic compatibility (EMC): Testing and measurement techniques - Electrical Fast Transient/Burst Immunity Test
12/KN4e	KN 61000-4-4 (Annex 1-3) RRA Announce 2010-6 (Dec. 24, 2010): Electromagnetic compatibility (EMC): Testing and measurement techniques - Electrical Fast Transient/Burst Immunity Test
12/KN5a	KN 61000-4-5 with RRL Notice No. 2005-130 (Dec. 27, 2005): Surge Immunity Test
12/KN5e	KN 61000-4-5 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Surge Immunity Test
12/KN5e	KN 61000-4-5 (Annex 1-4) RRA Announce 2010-6 (Dec. 24, 2010): Conformity Assessment Procedure for EMS (Surge Immunity Test)
12/KN6a	KN 61000-4-6 with RRL Notice No. 2005-130 (Dec. 27, 2005): Electromagnetic compatibility (EMC): Testing and measurement techniques - Immunity to conducted disturbances,

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12/KN6c	KN 61000-4-6 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Electromagnetic compatibility (EMC): Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields
12/KN6e	KN 61000-4-6 (Annex 1-5) RRA Announce 2010-6 (Dec. 24, 2010): Electromagnetic compatibility (EMC): Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields
12/KN8a	KN6100048 with RRL Notice No. 2005-130 (Dec. 27, 2005): Power Frequency Magnetic Field Immunity Test
12/KN8c	KN 61000-4-8 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Power Frequency Magnetic Field Immunity Test
12/KN8e	$KN\ 61000\text{-}4\text{-}8$ (Annex 1-6) RRA Announce 2010-6 (Dec. 24, 2010): Conformity Assessment Procedure for EMS (Power Frequency Magnetic Field Immunity Test)
12/RRA04b	RRA 2014-09 and RRA 2014-38 (June 23, 2014) K only: Technical Requirements and Test Methods for Electromagnetic Susceptibility; Korean only (See specific annexes listed on scope)
12/RRA106	RRA Public Notification 2010-6, December 24, 2010 (K only): Conformity Assessment Procdure for Electromagneite Susceptibility (K only)
12/RRA1117	RRA Public Notification 2011-17, K only (July 5, 2011): Technical Requirements for Electromagnetic Susceptibility, K only

Product Safety Test Methods

12/60601ab IEC 60601-1-2, Ed. 3.0 (2007): Medical electrical equipment - Part 1-2: General requirements for safety - Collateral standard: Electromagnetic compatibility - Requirements and tests

12/60601ac KN 60601-1-2 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Medical electrical equipment - Part 1-2: general requirements for safety - collateral standard: electromagnetic

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12/60601h1 EN 60601-1-2 (2007): Medical electrical equipment - Part 1-2: General requirements for

safety - Collateral standard: EMC - Requirements and tests

MIL-STD-462: Conducted Emissions

12/A20 MIL-STD-461 Version F Method CE102
 12/A21 MIL-STD-461 Version F Method CE106

MIL-STD-462: Radiated Emissions

12/D11 MIL-STD-461 Version F Method RE102
 12/D12 MIL-STD-461 Version F Method RE103

MIL-STD-462: Radiated Susceptibility

12/E16 MIL-STD-461 Version F Method RS103

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